

### Battery Materials Characterization Focusing on micro and surface analysis techniques

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# Battery materials characterization

#### Materials and structures

- Lithium ion battery structure
- Structural analysis
  - Anode Cathode Separator

Electrode cross sections

- Advanced analysis techniques Solid-Electrolyte Interface (SEI)
   Lithium analysis
   Combined AFM-in-SEM
- Technical Cleanliness & Contamination

Analytical Techniques **Electron Microscopy** SEM (-STEM) TEM (-STEM) FIB (-SEM) EDS, EBSD, WDS, EELS Surface Analysis (TOF-)SIMS LEIS XPS AFM-in-SEM Sample preparation Ion milling Laser micromachining

Spectrai









FE-SEM

#### **Manufacturing Process**



Anode Active material



Porosity measurement



Moderate pressResultIon conductivity

Too high compaction affects an ionic diffusion limitation and wettability.



Too much press





#### **Manufacturing Process**



#### Analysis Porosity of separator



#### 《Porosity》

- A smaller value is preferable from the viewpoint of <u>self-discharge</u>, prevention of micro-short circuit, and mechanical strength
- A larger value is preferable from the viewpoint of <u>charge-discharge</u> <u>cycle</u>. Normally, it is set to about 40-50%.

#### 《Hole diameter》

- The larger the maximum pore size leads to high ion conductivity.
- The smaller the maximum pore diameter leads <u>the less self-discharge</u> and <u>micro-shorting occur</u>.
- The larger the average pore diameter leads the faster the permeation rate of the electrolyte (better liquid absorption).
- If the pore size non-uniformity is large, the flow of ions becomes nonuniform, leading to <u>deterioration in cycle characteristics</u>.
- The average pore size is usually set at around 0.1 to 0.5  $\mu m.$

Self discharge, conductivity, etc





FlexSEM1000



Samples provided by courtesy of Hajime Okui, DAINEN MATERIAL Co., Ltd.





#### **Manufacturing Process**



Dispersion among active material, conductive additive and binder in Mixing Process

#### Cathode: NCM



Distribution of conductive additive and binder around active material.



Samples provided by courtesy of Hajime Okui, DAINEN MATERIAL Co.,Ltd.



#### Result

Low capacity

Mixing/

Dispersing

**Manufacturing Process** 

Materials

Upper Middle Lower Whole

Analysis













#### **Manufacturing Process** Mixing/ Assembly Forming/ After Coating/ Materials Calendering Cutting filling Dispersing Test/usage Drying /Housing Aging Analysis PSD & porosity after calendering Charge and discharge cycle causes Cathode Original 500cycle crack in active material. 100cycle 200cycle Active material Conductive additive Crack Binder 🌙 **Electrode foil**

Morphological Observation of Cathode Materials Nissan Arc Co., Ltd. (nissan-arc.co.jp)

Result

Lifetime





#### Manufacturing Process



#### **Electrode cross sections**





### Inert sample transfer – **Analysis of SEI layer after cycling**





To study the Solid – Electrolyte Interface (SEI) formed during cycling it is often necessary to transfer the sample in vacuum or inert gas before analysis in the SEM.



F Kα1 2



2.5um

### **Lithium Analysis**



#### 2 kV Windowless SDD



Spectrum with Oxford Extreme, windowless EDS detector.

Detector is capable in seeing the Li K $\alpha$  signal, but Li has only few electrons and bonded in an oxide state the probability to emit an X-ray photon is very small. 30 kV EELS



It is now possible to mount EELS (Electron Energy Loss Spectrometer) also in a 30kV SEM/STEM. With EELS it is possible to detect Li and also see its chemical bonding state.





# **EELS mapping of Li distribution**



#### **BF-STEM** image

#### EELS mapping (Li-K)



Instrument: HD2700 STEM, Analysis tool: EV3000, Accel voltage: 200 kV, magnification 60kx, Probe size: 0.5 nm Ip: 400 pA, mapping time: 10 sec.

# **Active Cathode Material Coating**



To study the amount of active cathode material coating that remains after cycling the LiCarbEx method was developed by Tascon. Low Energy Ion Scattering (LEIS) is a chemical

analysis technique with an information depth of 1 atomic layer (~0.3 nm).

Unfortunately, in practice, these cathode materials are covered with a layer of Li<sub>2</sub>CO<sub>3</sub> and LiOH that have to be removed before analysis of the coating coverage.

Intensity

Noble gas ions

Energy

LEIS principle



# **Combined AFM and SEM imaging**





Atomic Force Microscopy (AFM) can add functional imaging options to the topography and chemistry contrasts provided by SEM.

# **Technical cleanliness TecSa**

- EA8000 Combined transmission X-ray with uXRF elemental analysis,
   Fast screening for particles down to 20 um size Millions of particles/hour
- SEM with automated EDS for particle analysis
   Up to 30.000 particles/hour particles size down to <1um (but only surface inspection)
- Inline X-ray detection of particles Count and size only, no chemistry <100 m/min, particles >30-50 um (looks through the material)



Our technique portfolio

Electron Microscopy SEM (-STEM) TEM (-STEM) FIB (-SEM) EDS, EBSD, WDS, EELS

 Surface Analysis (TOF-)SIMS LEIS

- XPS
- AFM-in-SEM

# Spectral

In-situ tools Mechanical testing Nanoindentation Micromanipulation Electrical probing Heating, cooling, ...

Sample Preparation
Grinding, polishing
Cleaning
Ion milling
Laser micromachining



